

Issue Classification				Application/Control No.		Applicant(s)/Patent under Reexamination	
				10/084,372		LEE, KYUNG MEE	
				Examiner		Art Unit	
				BRIAN P. YENKE		2614	

ORIGINAL				CROSS REFERENCE(S)					
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)						
348	714	348	716	231.1					
INTERNATIONAL CLASSIFICATION				345	535	543	544	555	
H	0	4	N	7/12, 16, 26, 17 3	386	112			
				9/64	375	240.01			
G	0	6	F	12/02; 13/18 12/05; 13/00	382	235			
G	0	6	T	9/00	725	134	142		
G	0	6	K	9/36, 46	711	101	151	173	
				BRIAN P. YENKE PRIMARY EXAMINER				Total Claims Allowed: 14	
(Assistant Examiner) (Date)				<i>Brian P. Yenke</i> (Primary Examiner) (Date)				O.G. Print Claim(s) 1	O.G. Print Fig. 1 & 2
(Legal Instruments Examiner) (Date)				<i>B.J. Jowdy</i> (Date)					

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
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5	5	35	65	95	125	155	185
13	6	36	66	96	126	156	186
14	7	37	67	97	127	157	187
6	8	38	68	98	128	158	188
10	9	39	69	99	129	159	189
7	10	40	70	100	130	160	190
8	11	41	71	101	131	161	191
9	12	42	72	102	132	162	192
11	13	43	73	103	133	163	193
12	14	44	74	104	134	164	194
15		45	75	105	135	165	195
16		46	76	106	136	166	196
17		47	77	107	137	167	197
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19		49	79	109	139	169	199
20		50	80	110	140	170	200
21		51	81	111	141	171	201
22		52	82	112	142	172	202
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24		54	84	114	144	174	204
25		55	85	115	145	175	205
26		56	86	116	146	176	206
27		57	87	117	147	177	207
28		58	88	118	148	178	208
29		59	89	119	149	179	209
30		60	90	120	150	180	210